

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 4686-001		U.S. PATENT APPLICATION NO. 10/696,594	
				APPLICANT Hiroyuki NAGANO			
				FILING DATE October 30, 2003		GROUP 2878	
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
TH	JP 05-007664	01/1993	JAPAN	<div style="font-size: 4em; transform: rotate(-45deg); position: relative; top: 50%; left: 50%;">X</div>	<div style="font-size: 4em; transform: rotate(-45deg); position: relative; top: 50%; left: 50%;">X</div>	✓	
	JP 06-047161	02/1994	JAPAN			✓	
	JP 06-047168	02/1994	JAPAN			✓	
	JP 07-185120	07/1995	JAPAN			✓	
	JP 07-194837	08/1995	JAPAN			✓	
	JP 07-311869	11/1995	JAPAN			✓	
	JP 08-141202	05/1996	JAPAN			✓	
	JP 09-106471	04/1997	JAPAN			✓	
	JP 10-216347	08/1998	JAPAN			✓	
	JP 2001-022997	01/2001	JAPAN			✓	
	JP-2001-149631	06/2001	JAPAN			✓	
	JP-2001-293224	10/2001	JAPAN			✓	
	JP-2002-074468	03/2002	JAPAN			✓	
	JP-2003-016495	01/2003	JAPAN			✓	
TH	JP-2003-190616	07/2003	JAPAN			✓	
TH	JP-2003-305156	10/2003	JAPAN	✓			
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			
/Tramar Harper/				10/06/2006			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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